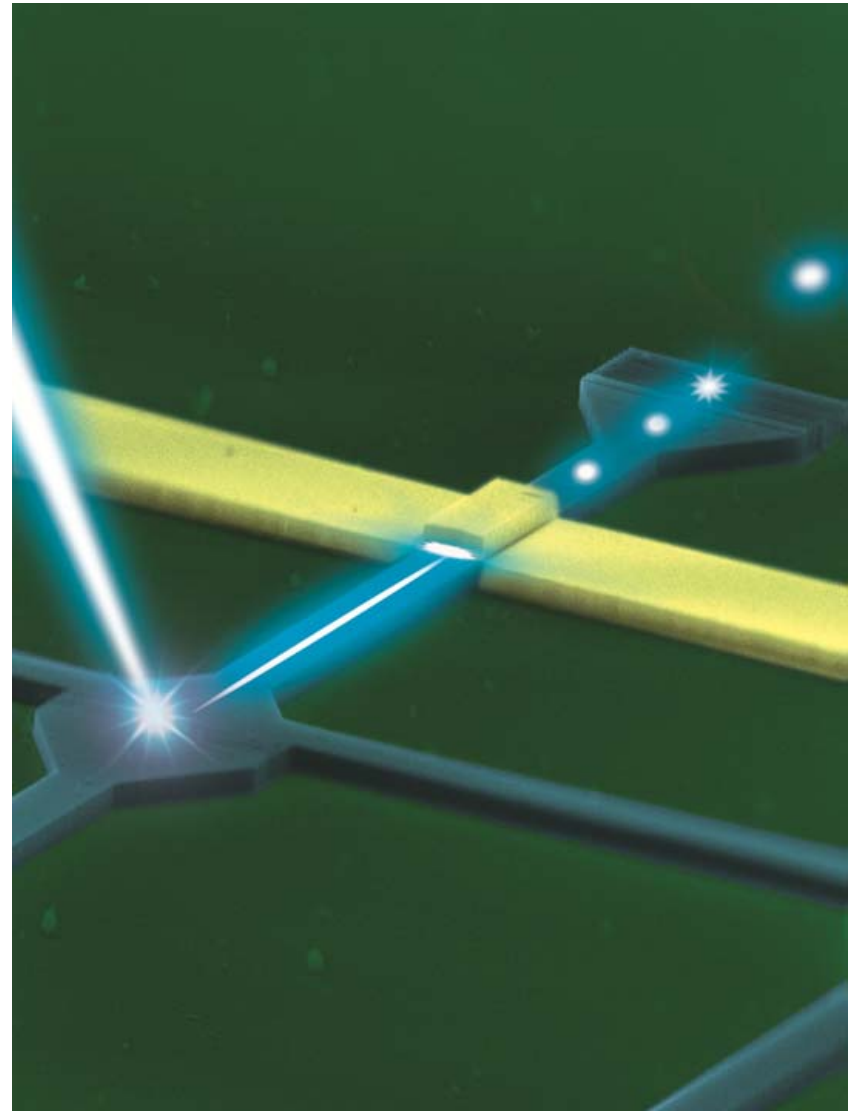


# Modulator

# Ultra-compact silicon nanophotonic modulator with broadband response

Volker J. Sorger<sup>1</sup>, Norberto D. Lanzillotti-Kimura<sup>1</sup>,  
Ren-Min Ma<sup>1</sup> and Xiang Zhang<sup>1,2,\*</sup>

**Keywords:** Modulator; silicon-on-insulator; ultra-compact.



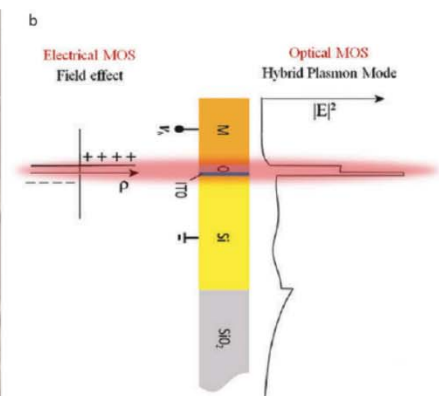
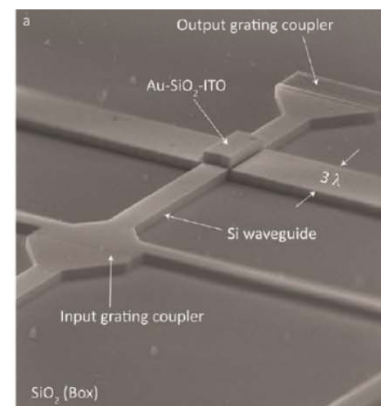
10.1117/2.1201305.004843

# A high-performance silicon-based plasmonic modulator

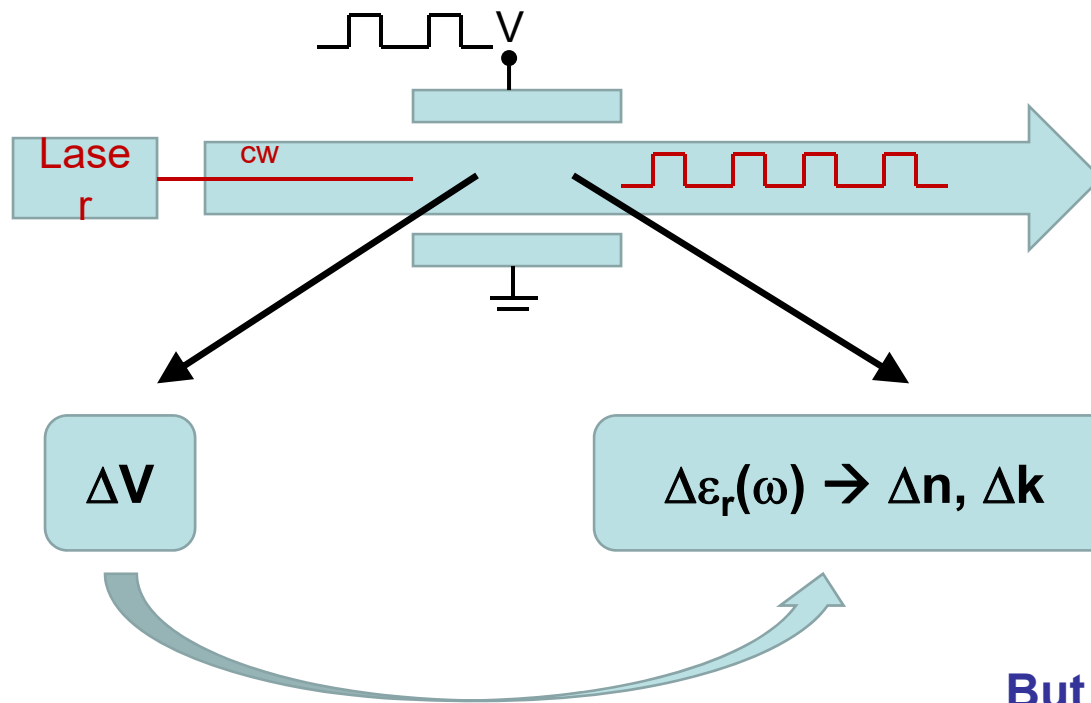
**Ren-Min Ma** and Xiang Zhang

*Photonic integrated circuits could be scaled down for future optical communication applications with the help of a new wavelength-scale modulator.*

To meet the ever-increasing global demand for bandwidth, optical interconnects are now being used to cover shorter distances. They will eventually account for all the interconnects inside a chip, setting a roadmap for reducing the photonic com-



# Electro-Optic Modulator (EOM)



## Materials

- LiNbO<sub>3</sub>
- Silicon
- Polymers
- ITO

**But Non-Plasmonic = Weak Effect**

$$\frac{\Delta n}{\Delta U_{bias}} = 3 \times 10^{-6} V^{-1} *$$

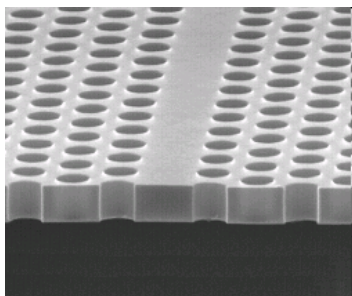
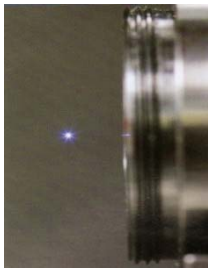
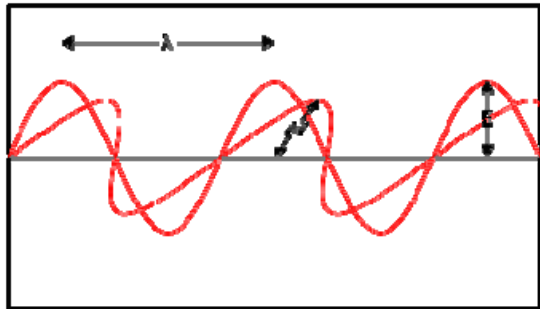
Franz Keldysh effects  
Pockels effects  
Kerr effects  
Free carrier effects

\* Intel Si-Photonics, e.g. **Nature** (2004)

# A Technological Opportunity: *Bridging the “Gap”*

## Light

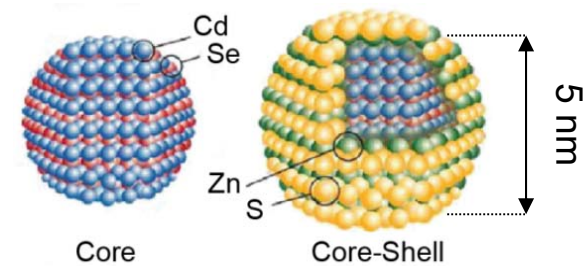
Visible / IR  $\lambda \sim 1 \mu\text{m}$



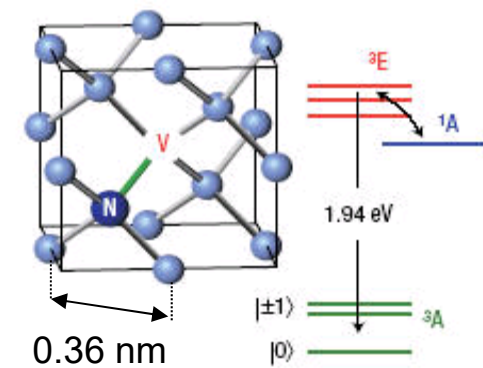
## Electrons

$\lambda_e \sim 1 \text{ nm}$

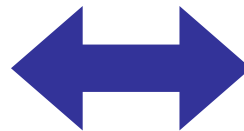
Quantum dot



NV-center



Weak  
Interaction



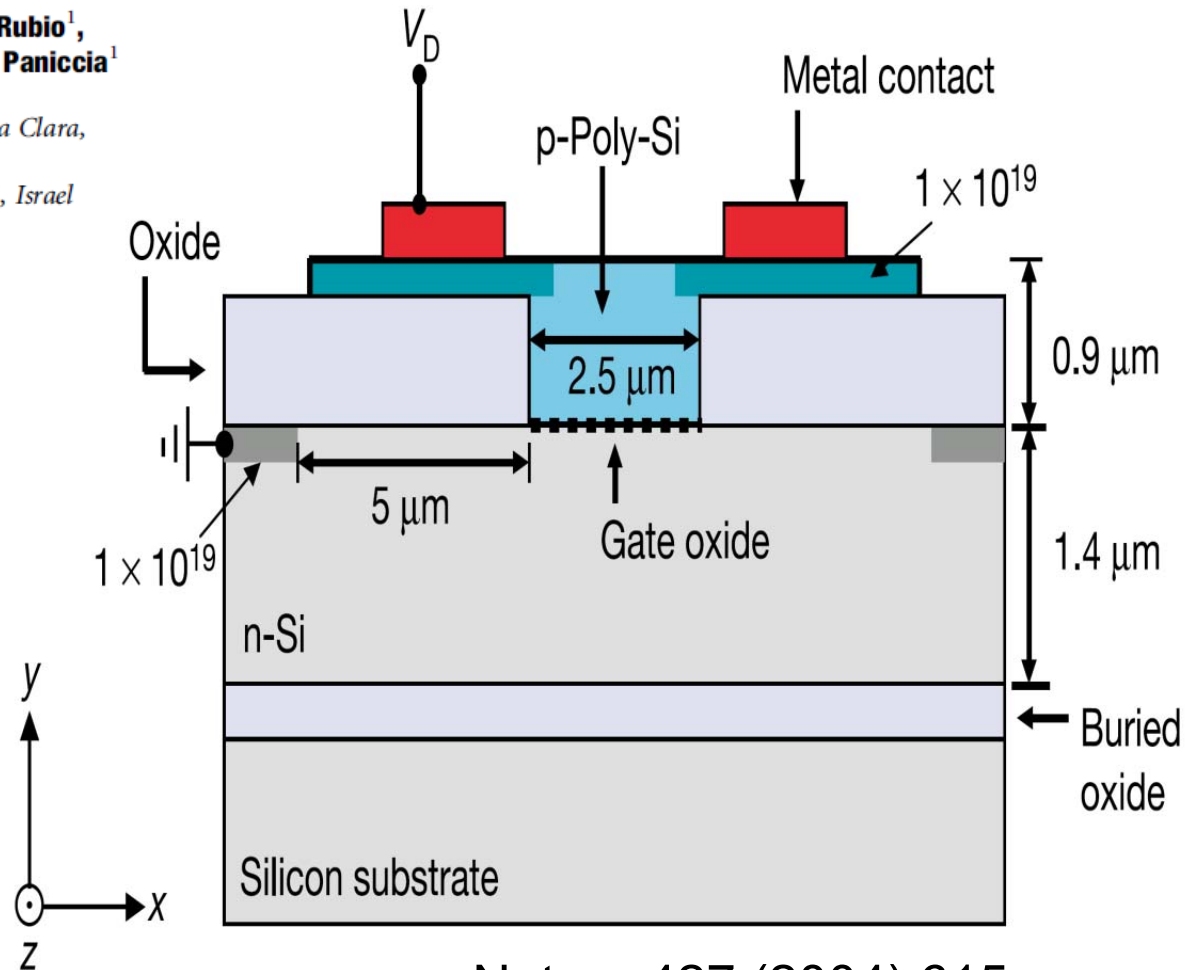
# MOS Silicon Modulator

## A high-speed silicon optical modulator based on a metal-oxide-semiconductor capacitor

Ansheng Liu<sup>1</sup>, Richard Jones<sup>1</sup>, Ling Liao<sup>1</sup>, Dean Samara-Rubio<sup>1</sup>,  
Doron Rubin<sup>2</sup>, Oded Cohen<sup>2</sup>, Remus Nicolaescu<sup>1</sup> & Mario Paniccia<sup>1</sup>

<sup>1</sup>Intel Corporation, 2200 Mission College Blvd, CHP3-109, Santa Clara,  
California 95054, USA

<sup>2</sup>Intel Corporation, S. B. I. Park Har Hotzvim, Jerusalem, 91031, Israel

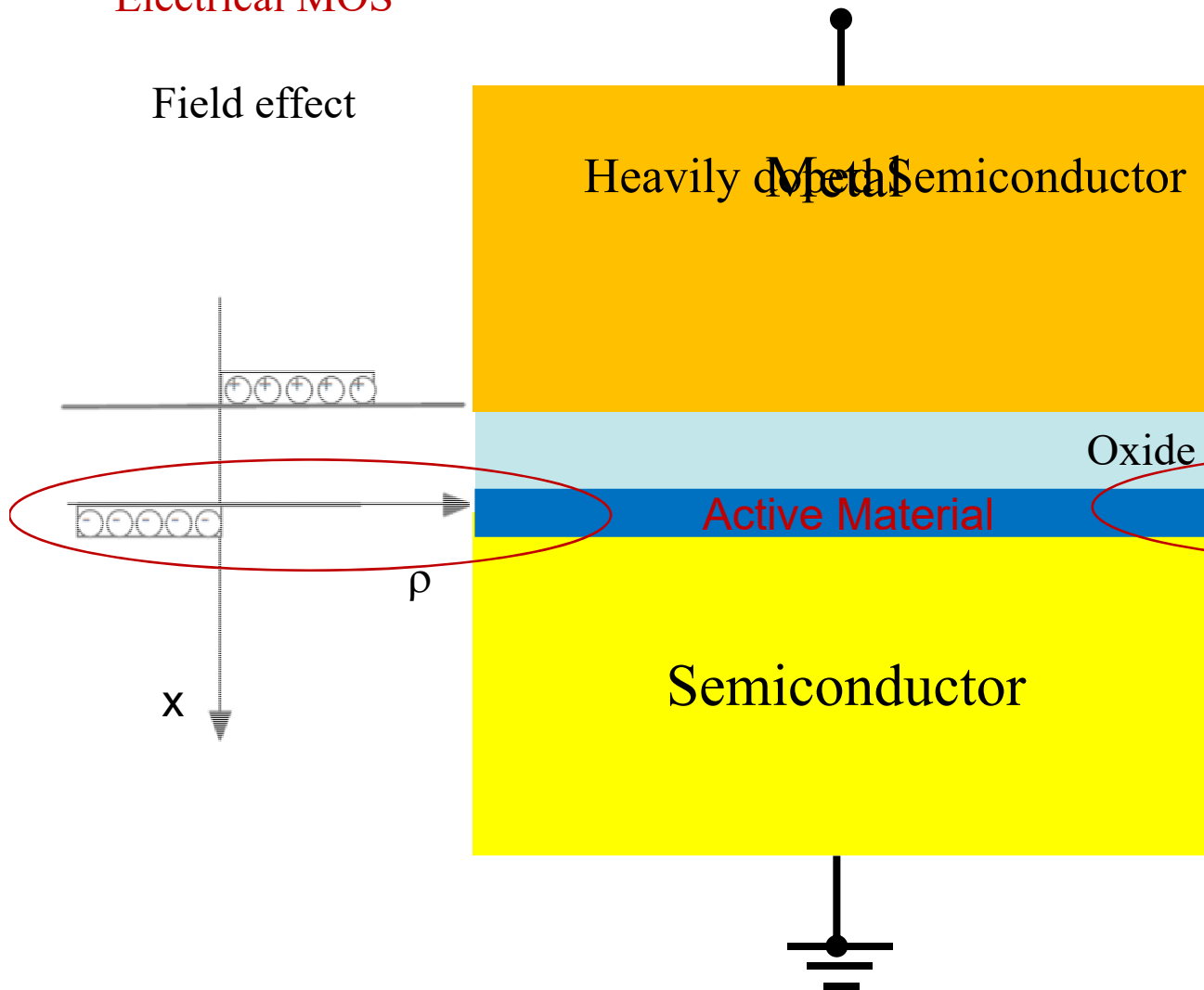


Nature 427 (2004) 615

# MOS Capacitor

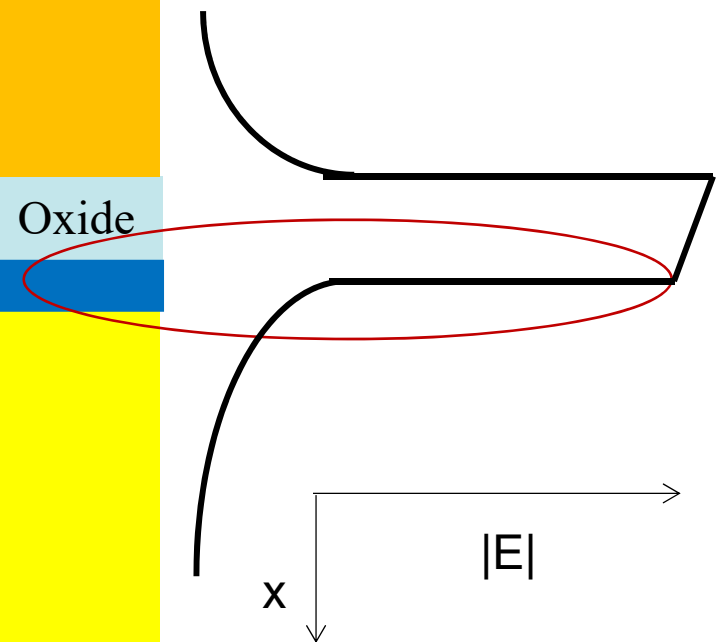
Electrical MOS

Field effect



Optical MOS

Hybrid Plasmon Mode



# Active Material : ITO

Indium tin oxide (ITO), is a heavily-doped n-type semiconductor with a large bandgap

Typically 90% In<sub>2</sub>O<sub>3</sub>, 10% SnO<sub>2</sub> by weight



[pubs.acs.org/NanoLett](http://pubs.acs.org/NanoLett)

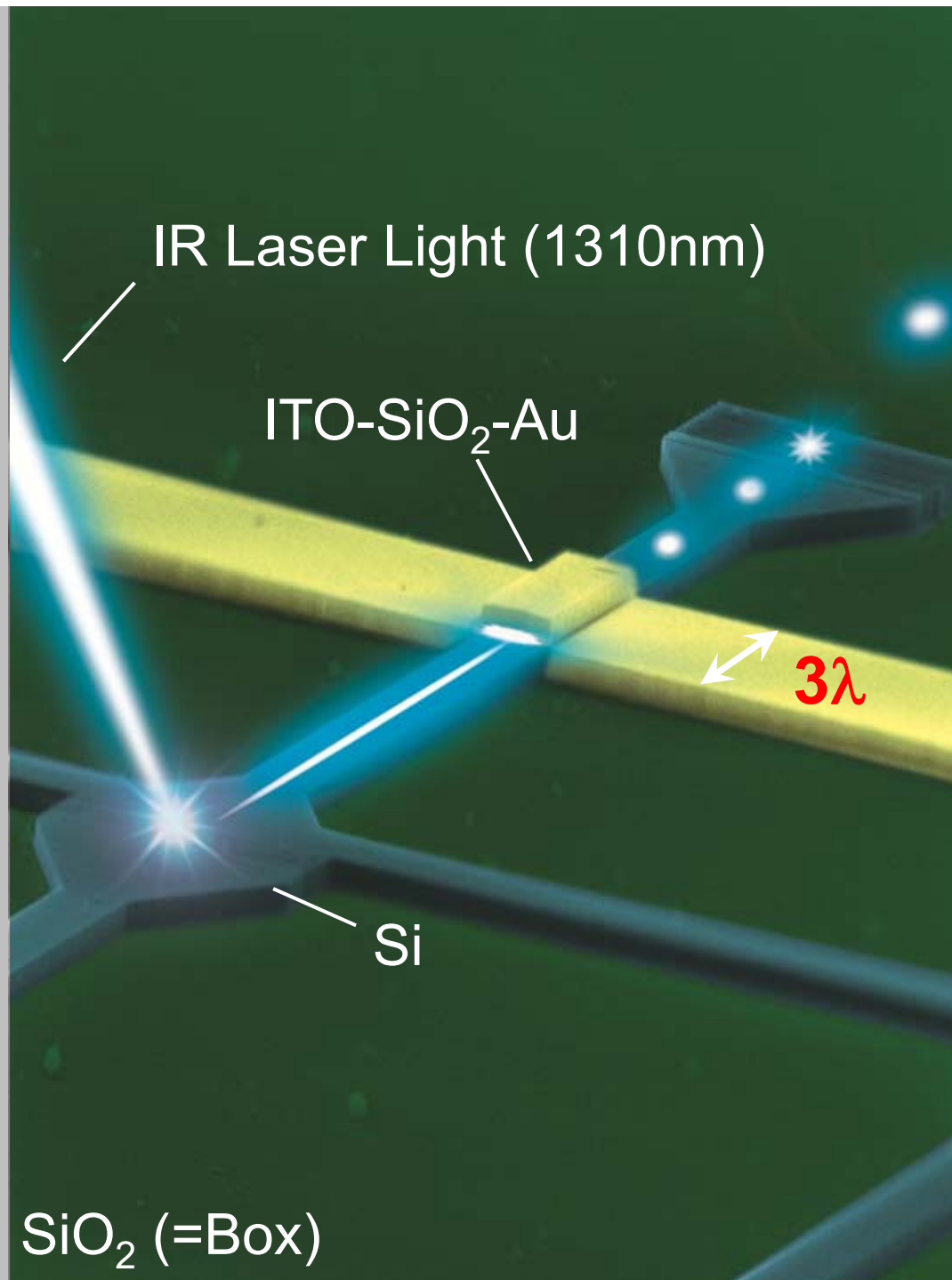
## Unity-Order Index Change in Transparent Conducting Oxides at Visible Frequencies

Eyal Feigenbaum,<sup>\*,†</sup> Kenneth Diest,<sup>†,§</sup> and Harry A. Atwater

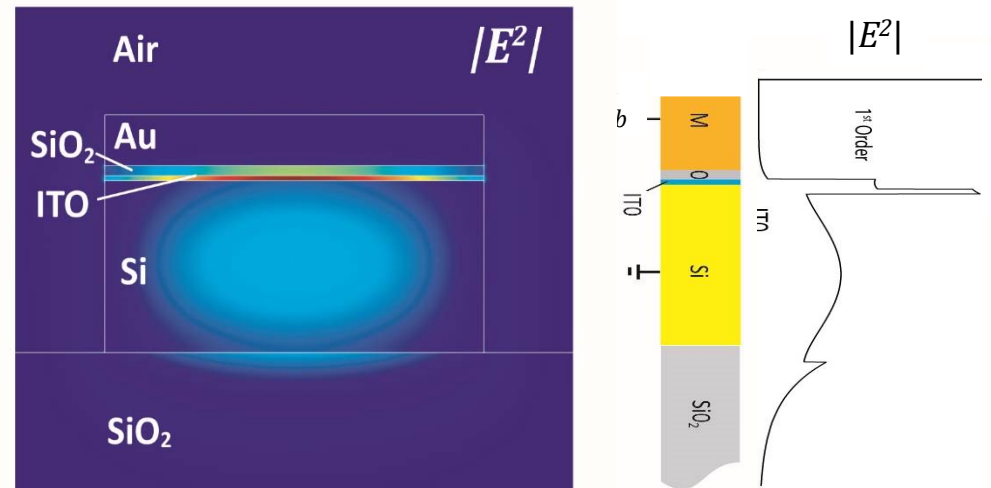
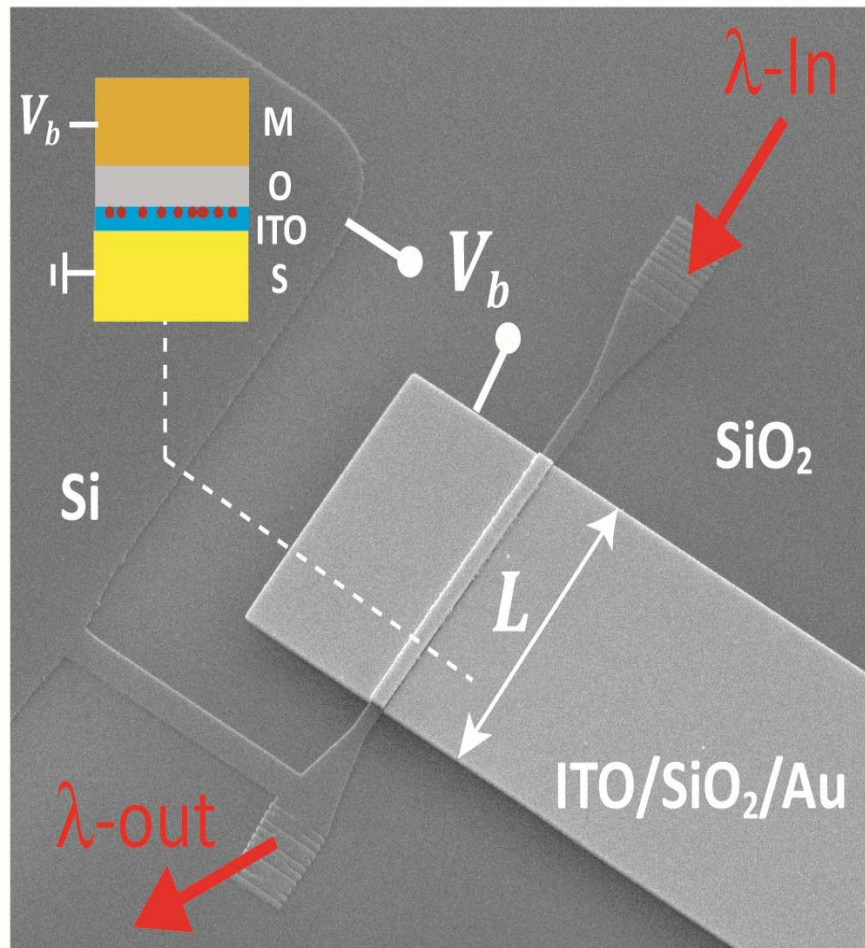
Thomas J. Watson Laboratory of Applied Physics, California Institute of Technology, Pasadena, California 91125

*Nano Lett.* **2010**, 10, 2111–2116

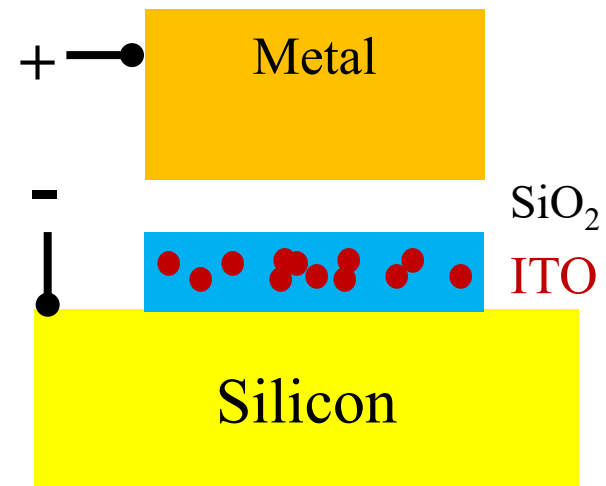




# Ultra-compact Si-based Modulator



Optical MOS = Hybrid Plasmon Mode

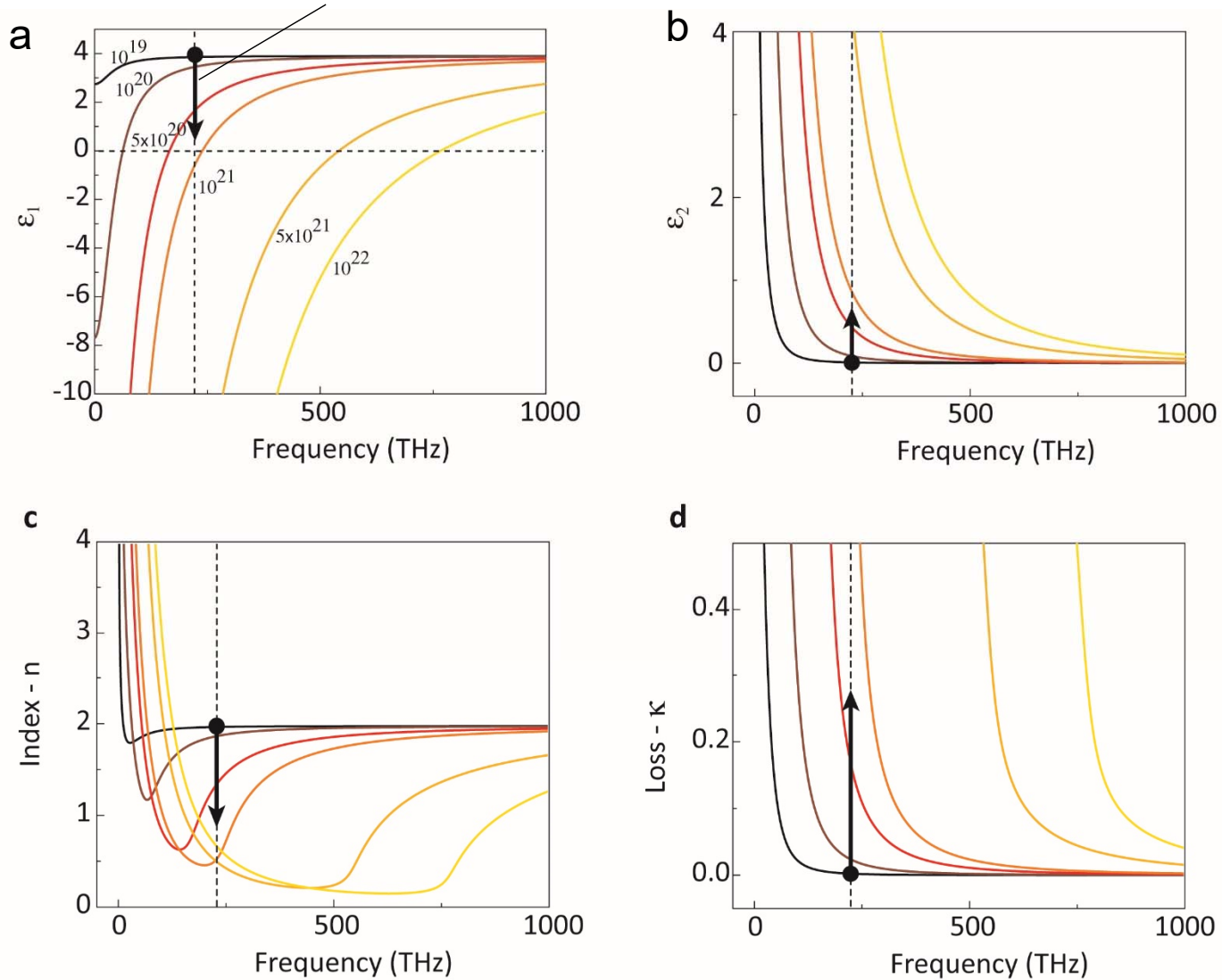


Electrical MOS = Field effect

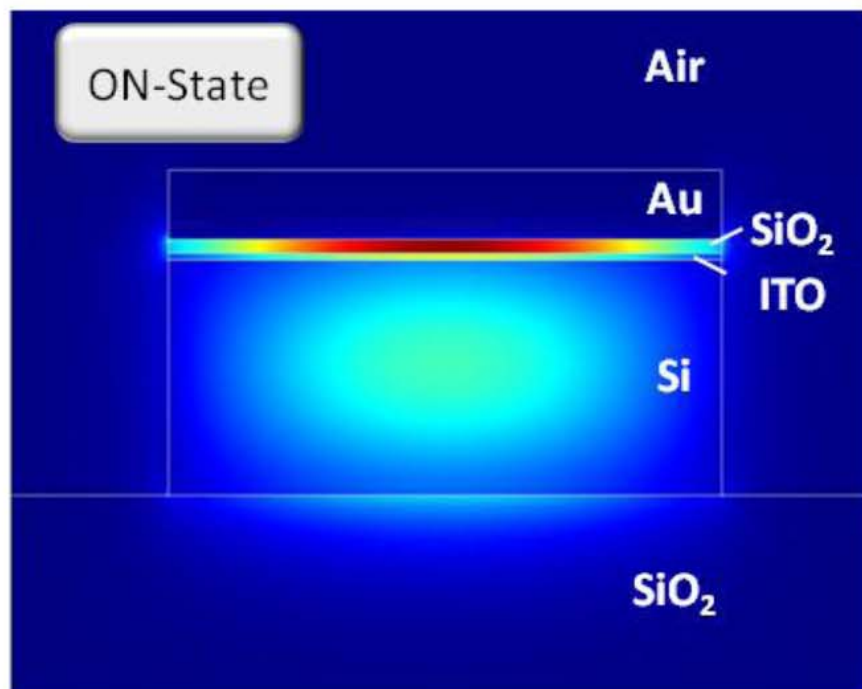
# ITO Optical Properties at Biases

$$n_0 \sim 10^{19} \text{ cm}^{-3}$$

$$\Delta n_e = 6 \times 10^{20} \text{ cm}^{-3}$$



# Electric field densities for the ON and OFF state

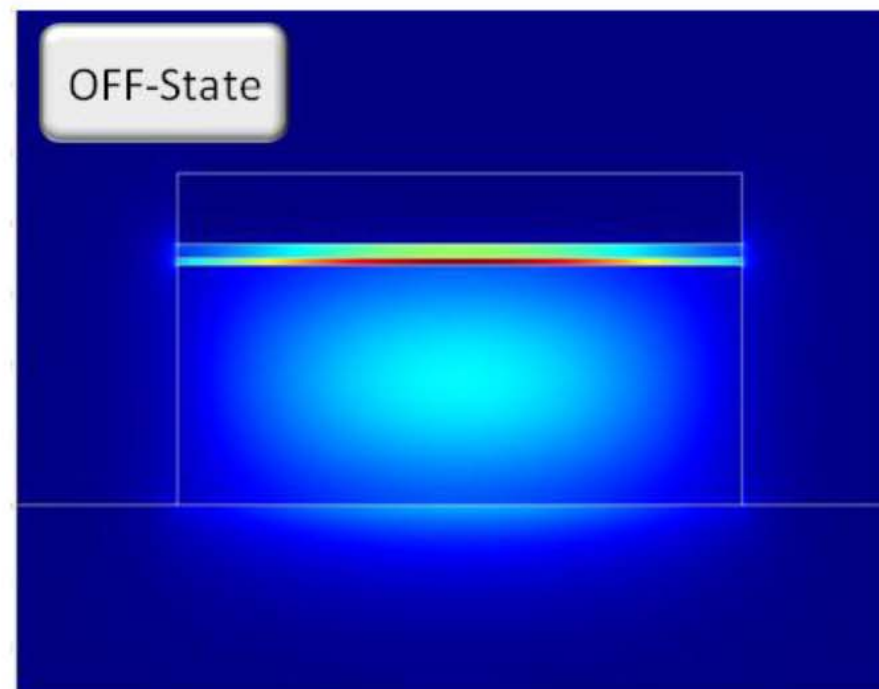


W/O bias

ITO → Semi. → larger  $n$ , smaller  $k$

More field in SiO<sub>2</sub> and Si

Low insertion loss



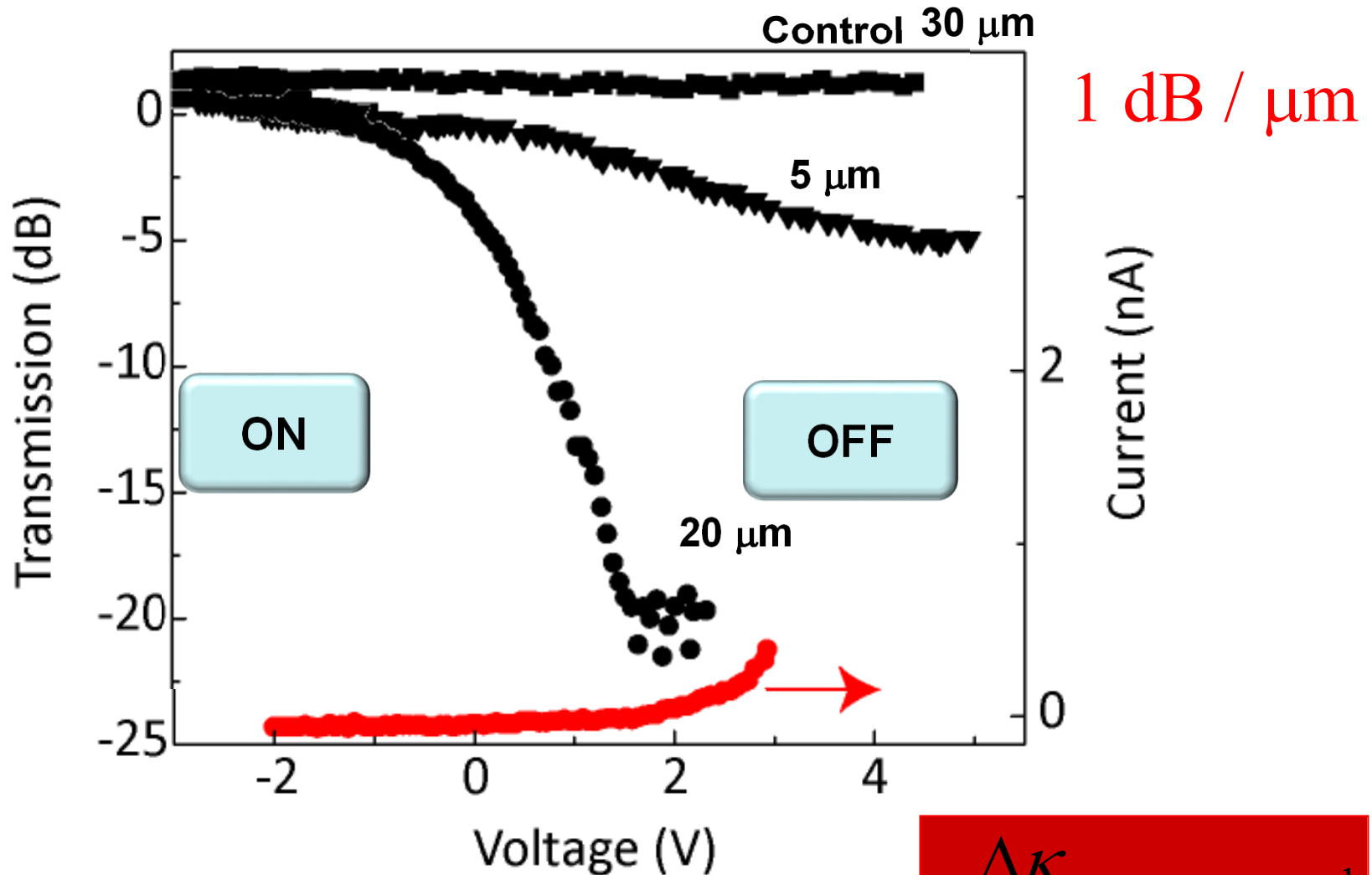
W/ bias

ITO → Metal → smaller  $n$ , larger  $k$

More field in ITO

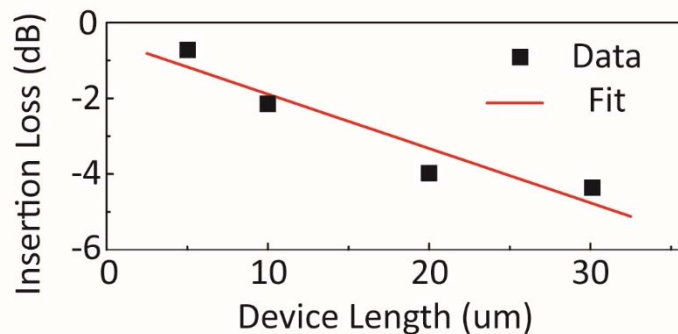
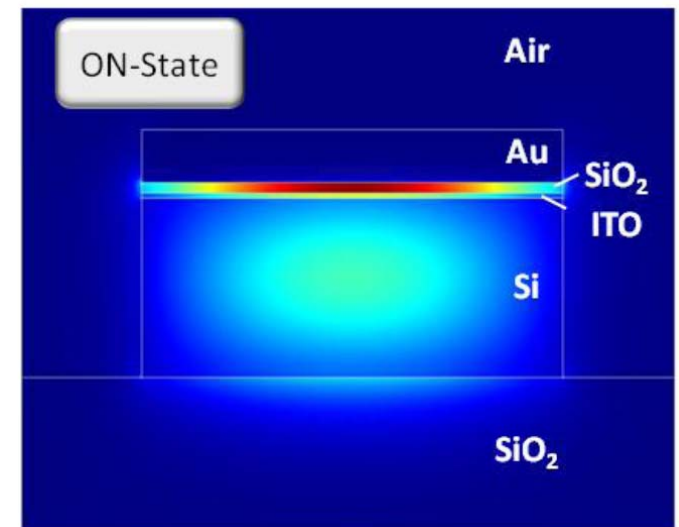
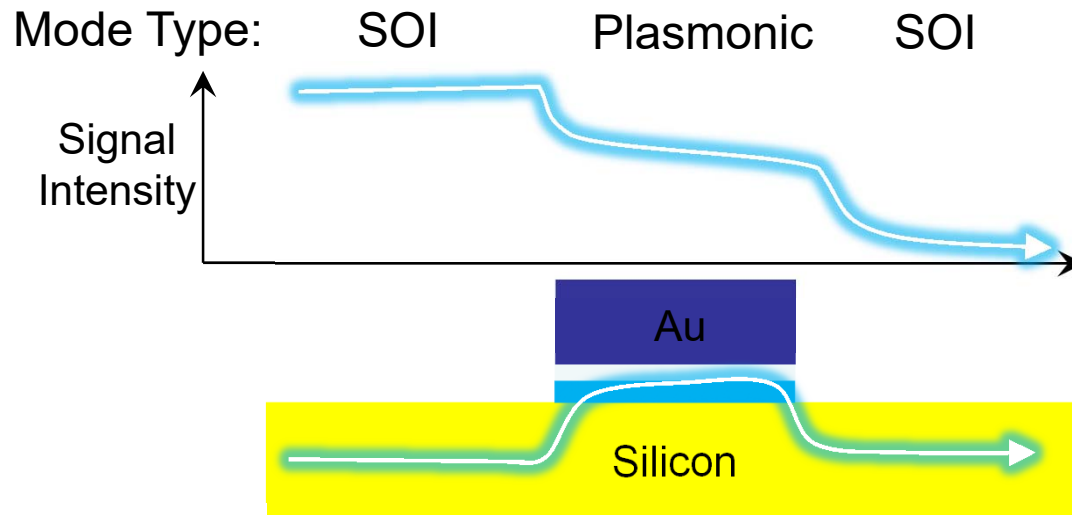
High modulation strength

# High Performance Modulation



$$\frac{\Delta\kappa}{\Delta U_{bias}} \approx 1\%V^{-1}$$

# Low Insertion Loss (on-chip)



## Low Insertion loss

- -0.25dB / SOI-MOS coupler
- -0.14 dB /  $\mu\text{m}$

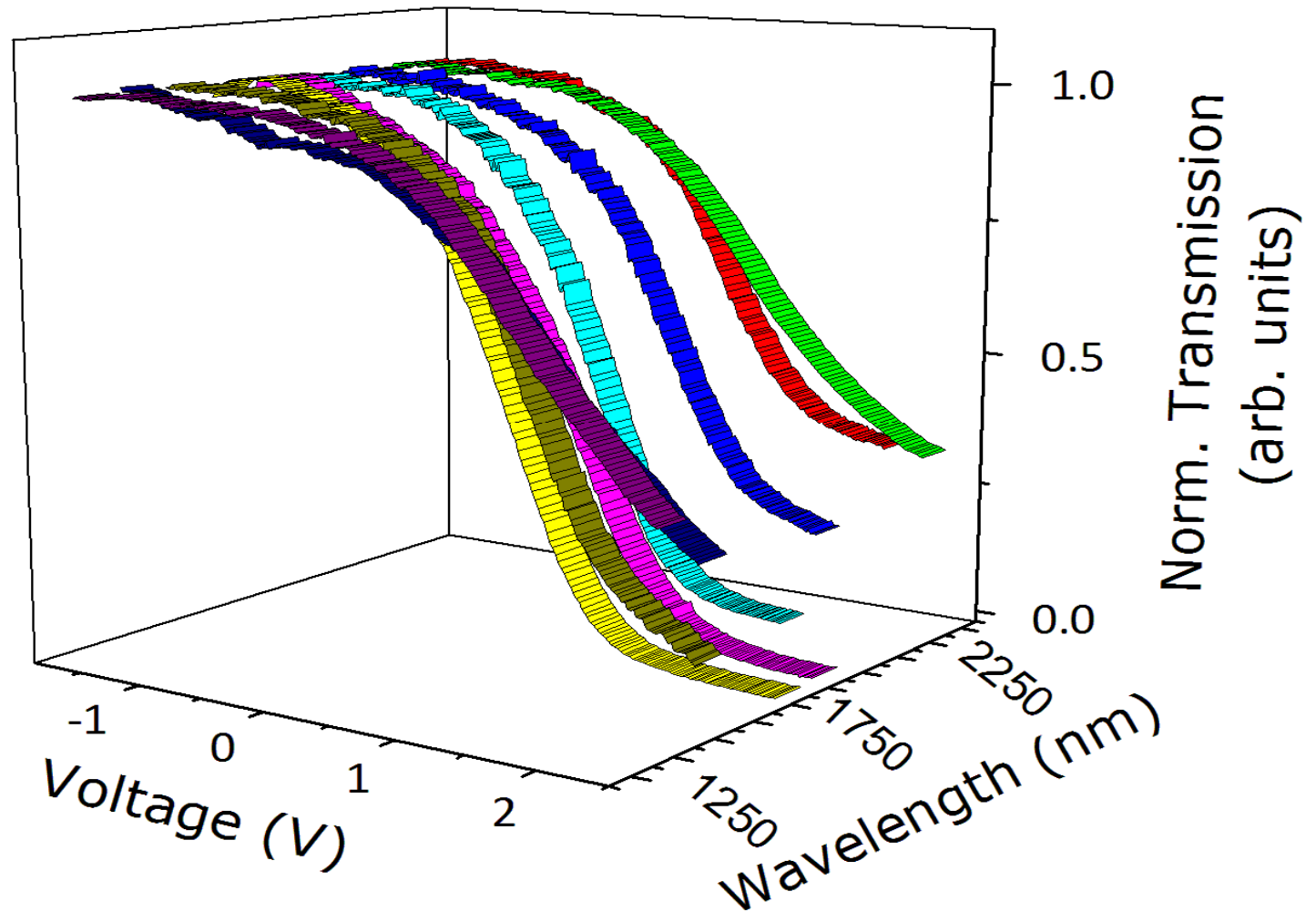
\*\*Intel Group Nature (2004)

$$\Sigma \approx -6\text{dB}^{**}$$

$$\Sigma \approx -1\text{dB}^*$$

\*5  $\mu\text{m}$  long device

# Modulation Bandwidth $\rightarrow$ WDM



Operation Bandwidth  $> 1000$  nm



# Summary

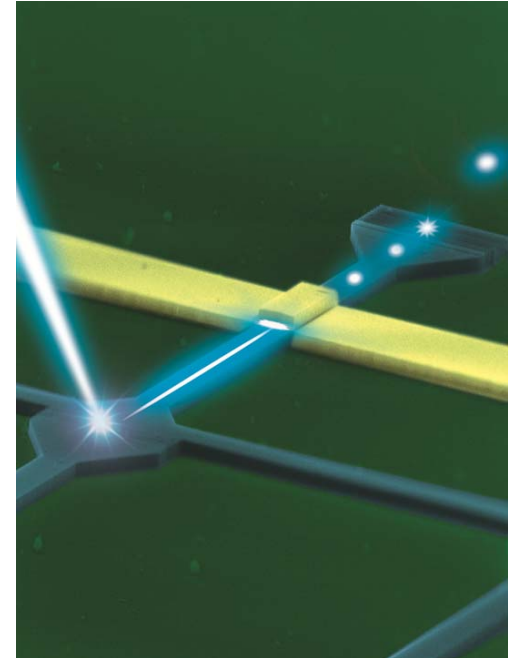
- An ultra-compact Si-based plasmonic modulator

- High Modulation Strength

- Ultra-Compact

- Low Insertion Loss

- Broadband



Optical MOS = Hybrid Plasmon Mode

Electrical MOS = Field Effect